# Now Now up to 26 GHz



### Spectrum Analyzer R&S FSU

### The new high-end spectrum analyzer with unmatched performance

### Features

#### Versatile resolution filters

• Gaussian, FFT, channel, RRC

#### **Comprehensive test routines**

- TOI, OBW, CCDF
- Channel power, ACPR
- ACPR in time domain

#### Full choice of detectors

 Auto Peak, Max Peak, Min Peak, Sample, RMS, Average, Quasi Peak

#### **Optional electronic attenuator**

#### GSM/EDGE

Code domain power for 3GPP

### Speed

- Fast ACP test routine in time domain
- User-configurable list for fast measurements at frequencies of interest
- Up to 60 measurements/s in time domain via IEC/IEEE bus (including trace data transfer)

### Unmatched performance

#### Unmatched dynamic range

- ◆ TOI typ. +25 dBm
- 1 dB compression +13 dBm
- Phase noise typ. –123 dBc/Hz at 10 kHz offset typ. –160 dBc/Hz at 10 MHz offset
- Excellent display linearity <0.1 dB</li>
- 84 dB ACLR/3GPP with noise correction



### **Milestones**

The name Rohde&Schwarz has been synonymous with innovative spectrum analyzers since 1986, the unique features of which have repeatedly set standards in this technology. Examples are the analyzers of the R&S FSE and R&S FSIQ families.

The Spectrum Analyzer R&S FSU is another milestone. New circuit concepts, advanced RF components, A/D converters and ASIC technology, extensive experience gained from a variety of applications and customer requirements - all this combines to form a solid basis on which the R&S FSU was developed. Its unparalleled features enable the use of new test methods - to your advantage. The future-oriented concept combines unprecedented performance with continuity. The R&S FSU is compatible with the R&S FSE and R&S FSIQ, the industry standards to date. Test routines and sequences generated for the R&S FSE or R&S FSIQ can be used on the R&S FSU too. The R&S FSU family thus secures your investment.

The operating concept of the top analyzer R&S FSU is the same as that of the general-purpose analyzer R&S FSP, so these instruments offer a uniform platform for a variety of applications.

#### The R&S FSU family

R&S FSU3	20 Hz to 3.6 GHz
R&S FSU8	20 Hz to 8 GHz
R&S FSU 26	20 Hz to 26 GHz

### Rohde&Schwarz innovation in spectrum analyzers

- 1986 R&S FSA first colour display, first spectrum analyzer to feature –154 dBm (6 Hz) displayed average noise level without the use of preamplifiers, quasi-continuously variable resolution bandwidths, phase noise optimization
- 1995 **R&S FSE** fastest analyzer
- 1996 **R&S FSE** first spectrum analyzer with RMS detector
- 1997 **R&S FSE-B7** universal vector signal analysis and spectrum analyzer capability combined for the first time
- 1998 **R&S FSIQ** first analyzer offering 75 dB dynamic range for UMTS/WCDMA ACLR measurements

- 1999 **R&S FSP** 0.5 dB total measurement uncertainty as standard, fast ACP test routines in time domain, digital channel filters, CCDF
- 2000 **R&S FSP-B25** first electronic attenuator for wear-free use in production
- 2001 **R&S FSU** 0.3 dB total measurement uncertainty, 50 MHz resolution bandwidth, +25 dBm TOI



### Performance surpassing all expectations

### R&S FSU – ideal for signals requiring wide dynamic range

The R&S FSU even surpasses the proven excellent RF data of the R&S FSE and R&S FSIQ families. Measurements calling for an extremely wide dynamic range become even simpler, faster and more reliable — in development, quality management and production. The R&S FSU can rightly be called the new reference in spectrum analysis, with an unprecedented dynamic range:

- ◆ TOI >20 dBm, typ. +25 dBm
- 1 dB compression
  (0 dB RF attenuation): +13 dBm
- Displayed average noise level: —158 dBm (1 Hz bandwidth)
- 77 dB ACLR typ. for 3GPP, 84 dB typ. with noise correction
- HSOI 55 dBm typ.
- Phase noise: –160 dBc/Hz typ. at 10 MHz carrier offset



These characteristics make it easy to find small spurious signals even in the presence of strong carriers (e.g. at a base station).

For 3GPP adjacent-channel power measurements, a figure of 84 dB ACLR allows good adjacent-channel power ratios to be verified and demonstrated very simply and with high accuracy. Build your node B better than others, and prove it.

The high harmonic second-order intercept point means optimum dynamic range for multichannel cable TV measurements.

#### Wealth of functions

The R&S FSU is launched with the most abundant functionality available on the spectrum analyzer market. All major functions come straight away in the basic unit:

Highly selective digital filters from 10 Hz to 100 kHz Fast FFT filters from 1 Hz to 30 kHz Channel filters from 100 Hz to 5 MHz **RRC** filters 1 Hz to 50 MHz resolution bandwidth QP detector and EMI bandwidths 200 Hz. 9 kHz. 120 kHz 2.5 ms sweep time in frequency domain 1 µs sweep time in time domain Number of measurement points/trace selectable between 155 and 10001 Time-selective spectrum analysis with gating function GPIB interface, IEEE 488.2 RS-232-C serial interface, 9-pin SUB-D connector VGA output, 15-pin SUB-D PC-compatible screenshots on diskette or hard disk Up to 20 measurements/s in manual mode Up to 30 measurements/s on GPIB interface SCPI-compatible GPIB command set R&S FSE/R&S FSIQ-compatible GPIB command set Fast ACP measurement in time domain Statistical signal analysis with CCDF function RMS detector of 100 dB dynamic range Transducer factor for correcting antenna or cable frequency responses 2-year calibration cycle 3-year warranty<sup>1)</sup> External reference from 1 MHz to 20 MHz in 1 Hz steps GSM/EDGE modulation measurements (with option R&S FS-K5)

1) Except parts subject to wear and tear (e.g. attenuators)

### Ready today for tomorrow

Functions like

- CCDF analysis
- Fast ACP measurement in time domain
- RMS detector
- Selection of filter characteristic
- Recording and readout of up to 2 x 512 ksamples of IQ data (8 MHz RF bandwidth)
- High measurement accuracy
- Excellent display linearity

and features like 50 MHz bandwidth mean that the R&S FSU is ready now for tomorrow's needs.

### Shorter development cycles through versatile functions

To handle the wide variety of measurement tasks in product development, an instrument must offer ample functionality and excellent performance in all areas of interest. The R&S FSU fully meets these requirements.

Full choice of detectors for adaptation to a wide range of signal types (Fig. 1):

- RMS
- 🔶 Auto Peak
- 🔷 Max Peak
- Min Peak
- Sample
- Average
- 🔶 Quasi Peak

The most versatile resolution filter characteristics and largest bandwidth found in a spectrum analyzer:

- Standard resolution filters from 10 Hz to 50 MHz in steps of 1, 2, 3, 5
- FFT filters from 1 Hz to 30 kHz
- 32 channel filters with bandwidth from 100 Hz to 5 MHz
- RRC filters for NADC and TETRA
- EMI filters: 200 Hz, 9 kHz, 120 kHz

AUTO

SELECT

DETECTOR

AUTO PEAK

1

Full range of analysis functions:

- Time-domain power in conjunction with channel or RRC filters makes the R&S FSU a fully-fledged channel power meter (Fig. 2)
- TOI marker (Fig. 3)
- Noise/phase-noise marker
- Versatile channel/adjacent-channel power measurement functions with wide selection of standards, user-configurable (Fig. 4)
- Split-screen mode with selectable settings
- CCDF measurement function (Fig. 5)
- Peak list marker for fast search of all peaks within the set frequency range (search for spurious)



### ...wide dynamic range and future-proof performance

Whether in synthesizer development or front-end design, additional applications add to the R&S FSU functionality while user-friendliness is maintained:

Phase Noise Measurement Software **R&S FS-K4** automates measurement over a complete offset frequency range and determines residual FM from the phase noise characteristic. This in conjunction with the R&S FSU's extremely low phase noise generally does away with the need for an extra phase noise measurement system, which can be difficult to operate anyway.

Noise Measurement Software **R&S FS-K3** is a convenient way to determine the noise figure of amplifiers and frequency-converting UUTs throughout the R&S FSU's frequency range, so enabling complete documentation. The high linearity and extremely accurate power measurement routines of the R&S FSU deliver precise and reproducible results. So why bother with a noise figure meter.







Noise figure

measurement

with Software

R&S FS-K3

En FS-K3 - O X Eile ENR LOSS Limit <u>Graph</u> <u>Device</u> Schematic Option . 🤏 📕 🗒 1 RF 135 MHz ENB: Me Overlay Count 14.20 dB Gain IE 0 Hz 9.85 dB LO LOSS In NF CL ME CL OL D Bb 00.0 2.70 d8 0 Hz LOSS Out Temp. Image Frg. 0.00 dB 249.7 K 0 Hz DIRECT ٠ Noise Figure /dE Gain /dB 10.00 20.00 Start [ 135 MHz Stop 155 MHz 9.00 18.00 Step [ 8.00 16.00 500 kHz 7.00 14.00 12.00 6.00 🔽 2nd Stage Con. DN 5.00 10.00 CAL 4.00 8.00 3.00 6.00 Single Freq: 2.00 4.00 140 MHz 1.00 2.00 C Single RUN 0.00 0.00 C Al Freq. STOP 135 MH+ 2 MH+ / DIV 155 MH+

Fast and simple analysis of anomalies: the cause – spurious or RFI – can easily be traced with the basic analyzer function without additional measuring equipment



### From GSM to UMTS...

### From GSM to UMTS – ready for 3G mobile radio

In conjunction with GSM/EDGE Application Firmware **R&S FS-K5**, the R&S FSU offers complete functionality for RF and modulation measurements in GSM systems. EDGE, which is the generation 2.5, is already included inthe R&S FS-K5 option.

- Phase/frequency error for GSM
- Modulation accuracy for EDGE with:
  - EVM and ETSI-conformant weighting filters
  - 00S
  - 95:th percentile
  - Power versus time with synchronization to midamble
  - Spectrum due to modulation
  - Spectrum due to transients

The above features plus wide dynamic range make the R&S FSU an ideal tool in base station development and testing. This is enhanced by excellent characteristics ready incorporated in the standard unit, e.g. <0.3 dB total measurement uncertainty, gated sweep and IF power trigger.

Even in its basic version, the R&S FSU offers the functionality and characteristics needed to develop, verify and produce 3G mobile radio systems:

 RMS detector, provided as standard in Rohde&Schwarz analyzers for many years and allowing accurate power measurements independently of signal form; 3GPP specifications stipulate RMS power measurements for most tests



Measurement of modulation accuracy on EDGE burst



Measurement of power ramp on EDGE burst

### ...ready for 3G mobile radio

- ACP measurement function for 3GPP with 3.84 MHz bandwidth RRC filter for standard-conformant adjacentchannel power measurements with a dynamic range limit of 77.5 dB
- Dedicated CCDF measurement function that determines the probability of instantaneous signal power exceeding average power. CCDF measurement is indispensable to determine optimum transmit power for CDMA signals, assuming that clipping at known, short intervals is tolerable.

## Standard 3GPP modulation and code domain power measurements

- For BTS/node B signals: Application Firmware R&S FS-K72
- For UE signals: Application Firmware R&S FS-K73
- High measurement speed of 4 s/measurement
- Code domain power and CPICH power
- EVM and PCDE
- Code domain power vs. slot
- EVM/code channel
- Spectrum emission mask



Dynamic range of R&S FSU for adjacent-channel power measurement on WCDMA signal without noise correction



WCDMA code domain power measurement with R&S FSU and R&S FS-K72

### What can we do ...

#### Short test cycles, high throughput

The R&S FSU is just the right instrument for this. Fast data transfer on the IEC/IEEE bus or an Ethernet LAN plus intelligent routines optimized for speed make for very short measurement times:

- FAST ACP: for the major mobile radio standards with high reproducibility and accuracy
- List mode: combined measurement of various parameters at a single command
- Fast time domain power measurement using channel or RRC filters
- Up to 60 measurements/s in zero span via IEC/IEEE bus including trace data transfer
- Fast-sweeping FFT filters for spurious measurement at low levels
- Fast frequency counter: 0.1 Hz resolution for a measurement time of <30 ms</li>

### Downtime and repair time cut to a minimum

### Limited lifetime of mechanical attenuators due to high throughput

The R&S FSU-B25 option solves this problem. The electronic attenuator with 25 dB setting range does away with any mechanical switching — so the R&S FSU's high accuracy is maintained without any early failure. A two-year calibration cycle minimizes downtime for instrument calibration.

### Spurious emission measurements without notch filter

The R&S FSU is an ideal choice for this type of measurement, even for tests on GSM base stations. The extremely low phase noise and high 1 dB compression point of the R&S FSU enable direct measurements without the use of extra automatic or manually tuned notch filters. This eliminates possible sources of error and makes measurements simpler and more reliable. Another step enhancing the reliability of your test system!

#### Existing programs for R&S FSE, R&S FSIO or R&S FSP can be used on R&S FSU

The R&S FSU complies with SCPI conventions and is IEC/IEEE-bus-compatible with respect to the R&S FSE and R&S FSIQ. These instruments can in most cases be directly replaced with no or only minor changes to the software. If changes have to be made, they affect only those program parts that concern the speedoptimized measurement routines of the R&S FSU.

#### **External frequency standards**

The R&S FSU accepts signals between 1 MHz and 20 MHz in steps of 1 Hz.



Effect of measurement uncertainty on production yield

### ...to boost your production yield?

#### Higher production yield

Enhanced measurement accuracy makes for higher production yield. The safety margins that usually compensate for the measurement uncertainty of test systems can be reduced, so increasing the accept (passed) region. Given the same spread of results, more products will pass the test. The R&S FSU helps you boost your production yield featuring a total measurement uncertainty of <0.3 dB ( $2\sigma$ ).

With 30 measurements/s in manual mode, minimum sweep time of 2.5 ms and 1 µs zero span as standard, the R&S FSU is ideal for time-critical applications. The highly selective, fast-sweeping digital filters featuring "analog response" allow measurements on pulsed signals as well as use of the built-in frequency counter.

	Sweeps/s	Sweeps/s
	span 10 MHz,	span 0 Hz,
	sweep time 2.5 ms	sweep time 100 µs
ASCII format	30	40
Binary IEEE754 format	50	60

#### Measurement speed on GPIB interface

Settings: display off, default coupling, single trace, 625 points



Measurement of adjacent-channel power versus time: FAST ACP



Remote control of R&S FSU via IEC/IEEE bus in list mode cuts down on measurement times

### Profit from the advantages of networking

### Versatile documentation and networking capabilities

The standard disk drive makes it easy for you to integrate results into documentation – simply save the screen contents as a BMP or WMF file and import them into your word processing system. To process trace data, save them as an ASCII file (CSV format), which not only documents trace data but also the main instrument settings.

### Make use of the advantages offered by networking

The option **R&S FSU-B16** opens up versatile networking capabilities:

- Link to standard network (Ethernet 10/100BaseT)
- Running under Windows NT, the R&S FSU can be configured for network operation. Applications like data output to a central network printer or saving results on a central server can easily be implemented. The R&S FSU can thus be optimally matched to a given work environment.
- You can import screen contents straight into your documentation programs by Word for Windows or an MS Excel macro and so immediately create data sheets for your products or documents for quality assurance.

Remote control by Ethernet is even simpler:

 PCAnywhere software: PCAnywhere allows mouse operation of the R&S FSU after assigning it a TCP/IP address. All elements of the R&S

FSU screen are represented by a soft front panel function; the complete R&S FSU screen shows on the remote PC. Special RSIB interface This links your application to the TCP/IP protocol and acts like an IEC/IEEE-bus driver. The RSIB interface is available for Windows and the UNIX world. The R&S FSU can be programmed via this interface just like on the familiar IEC/IEEE bus.



R&S FSU in networked operation



R&S FSU remotely controlled with PCAnywhere

### Specifications

Specifications apply under the following conditions:

30 minutes warm-up time at ambient temperature, specified environmental conditions met, calibration cycle adhered to, and total calibration performed. Data without tolerances: typical values only.

Data designated "nominal" apply to design parameters and are not tested. Data designated " $\sigma$  = xx dB" are shown as standard deviation

	R&S FSU3	R&S FSU8	R&S FSU 26
Frequency	l	l	I
Frequency range			
DC coupled	20 Hz to 3.6 GHz	20 Hz to 8 GHz	20 Hz to 26.5 GHz
AC coupled	1 MHz to 3.6 GHz	1 MHz to 8 GHz	10 MHz to 26.5 GHz
Frequency resolution		0.01 Hz	
Internal reference fr	equency (nominal)	with standard OC	XO
Aging per day 1)		1 x 10 <sup>-9</sup>	
Aging per year 1)		1 x 10 <sup>-7</sup>	
Temperature drift		8 x 10 <sup>-8</sup>	
(0°C to +50°C)			
Total error (per year) 1)		1.8 x 10 <sup>-7</sup>	
Internal reference fr	equency (nominal)	; option R&S FS-B	4
Aging per day 1)		2 x 10 <sup>-10</sup>	
Aging per year 1)		3 x 10 <sup>-8</sup>	
Temperature drift		1 x10 <sup>-9</sup>	
(0°C to +50°C)			
Total error (per year) 1)		5 x 10⁻ <sup>8</sup>	
External reference	1 MI	Hz to 20 MHz, 1 Hz s	steps
frequency			
Frequency display	with m	arker or frequency of	counter
Marker resolution	0.1 Hz to 10 kHz (dependent on span)		
Max. deviation	$\pm$ (marker frequency x reference error + 0.5 % x span		
(sweep time >3 x	$+10$ % x resolution bandwidth $+\frac{1}{2}$ (last digit))		
auto sweep time)			
Frequency counter	0.1 Hz to 10 kHz (selectable)		
resolution			
Count accuracy	$\pm$ (frequency x reference error + $\frac{1}{2}$ (last digit))		
(S/N >25 dB)			
Frequency span	0 Hz,	0 Hz,	0 Hz,
	10 Hz to 3.6 GHz	10 Hz to 8 GHz	10 Hz to 26.5 GHz
Span resolution/		0.1 Hz/1 %	
max. span deviation			
Spectral purity (dBc	(1Hz)), SSB phase	noise, f = 640 MH	Z
Residual FM		<1 Hz nominal	
Carrier offset			
10 Hz	typ. –73 dBc(1Hz	), with option R&S F	S-B4 typ. –86 dBc
100 Hz	<-90 d	Bc(1Hz), typ. –100 c	IBc(1Hz)
1 kHz	<-112 0	IBc(1Hz), typ. –116	dBc(1Hz)
10 kHz	<-120 d	IBc(1Hz), typ. –123	dBc(1Hz)
100 kHz	<-120 dBc(1Hz), typ123 dBc(1Hz)		
1 MHz	<-138 dBc(1Hz), typ144 dBc(1Hz)		
10 MHz	<-155 dBc(1Hz) nominal, typ160 dBc(1Hz)		
Sweep			
Span 0 Hz	1 µs	to 16000 s in steps	of 5%
Span ≥10 Hz	2.5 ms	s to 16000 s in steps	;≤10%
Max. deviation of		3%	
sweep time			
Sampling rate	31.25	ns (32 MHz A/D con	iverter)
Measurement in	with marker an	d display lines (reso	lution 31.25 ns)
time domain			

	R&S FSU3	R&S FSU8	R&S FSU26	
<b>Resolution bandwid</b>	ths			
Analog filters				
3 dB bandwidths	10 Hz to 20 N	1Hz in 1/2/3/5 sequ	ence, 50 MHz	
Bandwidth error	1			
10 Hz to 100 kHz		<3%		
200 kHz to 5 MHz		<10%		
10 MHz, 20 MHz		-30% to + 10%		
50 MHz	-30% to +10%	-30% to +10%	6 for f<3.6 GHz	
		-30% to +1009	% for f>3.6 GHz	
Shape factor –60 dB	-3 dB			
≤100 kHz		<6		
200 kHz to 2 MHz	<12			
3 MHz to 10 MHz		</td <td></td>		
ZU IVIHZ, 5U IVIHZ	  to nominal 1 Up to 10 MUp in 1/2/2/E consumption			
FET filters	1 HZ LU	10 101112 111 1/2/3/5 \$	equence	
3 dB bandwidths	1 Hz to	20 kHz in 1/2/3/5 so	allence	
Bandwidth error	1 112 10	<5% nominal	queille	
Shane factor		<3 nominal		
-60 dB: -3 dB		so noninar		
EMI filters				
6 dB bandwidths	2	00 Hz, 9 kHz, 120 kH	łz	
Bandwidth error		<3% nominal		
Shape factor		<6 nominal		
−60 dB : −3 dB				
Channel filters	-			
Bandwidths	1	00, 200, 300, 500 H	Ζ,	
	1, 1.5, 2, 2.4, 2.7, 3,	3.4, 4, 4.5, 5, 6, 8.5	9, 10, 12.5, 14, 15,	
	16, 18 (RRC), 20, 21, 24.3 (RRC), 25, 30, 50, 100, 150, 192,			
	200, 300, 500 kHz,			
Change faster	1, 1.228, 1.5, 2, 3, 5 MHz			
Suape lactor	<2 nominal			
-ou ub3 ub Bandwidth orror	2% nominal			
	270 1101111101			
Display range	displayed average noise level to 30 dBm			
Maximum input leve	el			
DC voltage	50 V			
(AC coupling)				
DC voltage		0 V		
(DC coupling)				
RF attenuation 0 dB				
CW RF power		20 dBm (= 0.1 W)		
Pulse spectral density		97 dBµV/1 MHz		
<b>RF</b> attenuation ≥10	dB	00.15.7.4.140		
CW RF power		30 dBm (= 1 VV)		
Nax. pulse voltage		150 V		
(10 uc)		THIVVS		
1 dB compression	±13 dBm nominal	⊥13 dBm nomin	al up to 3.6 GHz	
of input mixer	-	+10 dBm nominal	+7 dBm nominal	
(Λ dB BE attenua-		from 3.6 GHz	from 3.6 GHz	
tion)		to 8 GHz	to 26 GHz	
Intermodulation				
Third-order intermod	ulation			
Third-order inter-	>17 dBm,	>17 dBm,	>17 dBm,	
cept (TOI), level 2 x	typ. 20 dBm	typ. 20 dBm	typ. 20 dBm	
—10 dBm,	for $f = 10 \text{ MHz}$ to	for $f = 10 \text{ MHz}$ to	for $f = 10 \text{ MHz}$ to	
$\Delta f$ >5 x RBW or	300 MHz	300 MHz	300 MHz	
10 kHz, whichever is	>+20 dBm,	>+20 dBm,	>+22 dBm,	
the greater value	typ.+25 dBm	typ.+25 dBm	typ.+27 dBm	
	for f >300 MHz	for $f = 300 \text{ MHz}$	for $f = 300 \text{ MHz}$	
		to 3.6 GHz	to 3.6 GHz	
		>+18 dBm,	>+12 dBm,	
		typ.+23 dBm	typ. +15 dBm	
		tor $t = 3.6 \text{ GHz}$	tor $t = 3.6 \text{ GHz}$	
		to 8 GHz	to 26.5 GHz	

	R&S FSU3	R&S FSU8	R&S FSU26	
Second harmonic inte	ercept point (SHI)			
f <sub>in</sub> ≤100 MHz		>35 dBm		
100 MHz <f<sub>in</f<sub>	>45 dBm, typ. 55 dBm			
≤400 MHz				
400 MHz< f <sub>in</sub> ≤500 Hz	>52 dBm, typ. 60 dBm			
500 MHz< f <sub>in</sub> ≤1 GHz	>	45 dBm, typ. 55 dBı	n	
$1 \text{ GHz} < f_{in} \le 1.8 \text{ GHz}$		>35 dBm		
$f_{in} > 1.8 \text{ GHz}$	-	>80 dBm	nominal	
Displayed average n	OISE IEVEI	0 11 00		
(U dB RF attenuation,	HBW IU HZ, VBW 3	30 Hz, 20 averages, 1	trace average,	
Span o nz, terminatio	11 30 22)			
		~_80 dBm		
100 Hz		< 00 dBm		
1 kHz		<-110 dBm		
10 kHz		<-120 dBm		
100 kHz		<-120 dBm		
1 MHz		<-130 dBm		
10 MHz to 2 GHz	<—145 dBm, t	yp. –148 dBm	<—142 dBm,	
			typ. —146 dBm	
2 GHz to 3.6 GHz	<—143 dBm,	<—143 dBm,	<—140 dBm,	
	typ. —147 dBm	typ. —145 dBm	typ. —143 dBm	
3.6 GHz to 7 GHz	<-142 dBm,	<-142 dBm,	-	
7.011	typ. —146 dBm	typ. –144 dBm		
7 GHz to 8 GHz	-	<-140 dBm	- 142 JD	
3.0 GHZ 10 8 GHZ	-	_	<-142 0BM,	
0 CUz to 12 CUz			typ. – 146 dBm	
	-	_	<= 140 ubili, tvp 1/2 dBm	
13 GHz to 18 GHz	_	_	-138 dBm	
			tvn -141 dBm	
18 GHz to 22 GHz	-	_	<-137 dBm.	
			typ. —140 dBm	
22 GHz to 26.5 GHz	-	-	<-135 dBm,	
typ. –138 dBm				
Maximum dynamic range				
1 dB compression to		170 dB		
DANL (1 Hz)				
Immunity to interfer	ence			
f < 2 6 CHz		00 dP tup > 110 d	ס	
1 ≤ 3.0 0Hz f ≤ 3.6 GHz		>90 ub, typ. >110 ul >70 dB ty	0 /n 100 dB	
Intermediate frequen		270 UD, t	/p. 100 ub	
f < 3.6 GHz	2	>90 dB_tvp_>110 d	B	
3.6 GHz ≤f ≤4.2 GHz	-	typ. 7	70 dB	
f > 4.2 GHz		>70 dB, ty	′p. >90 dB	
Spurious responses		<-103 dBm		
(f > 1 MHz, without)				
input signal, 0 dB				
attenuation)				
Other spurious ( $\Delta f > 1$	00 kHz)			
$f_{in} < 2.3 \text{ GHz}$	<80 d	Bc (mixer level $\leq -1$	0 dBm)	
$2.3 \text{ GHz} \le 1_{\text{in}} < 4 \text{ GHz}$	<-/U d	Bc (mixer level $\leq -3$	(5 dBm)	
4 GHZ≤I <sub>in</sub> < 20.5 GHZ	0 U8>	BC (mixer level $\leq -1$	U dBm)	
Screen	625 x 500 pixels	(one diagram) max	2 diagrams with	
JUICEII	020 x 200 pixels (one diagram), max. 2 diagrams with			
Logarithmic level	1 dB 10 c	IB to 200 dB in step	s of 10 dB	
axis	. 35, 100	ab in otop		
Linear level axis	Linear level axis 10% of reference level ner level division 10 divisions or			
logarithmic scaling				
Traces	max. 6, with two d	iagrams on screen r	nax. 3 per diagram	
Trace detector	Max Peak, Min Pe	ak, Auto Peak (norm	ial), Sample, RMS,	
	Average, Quasi Peak			
Trace functions	Clear/Write, Max Hold, Min Hold, Average			
Number of measure-	625, setta	ible between 155 ar	na 100001	
ment points	in st	eps of about the fac	tor 2	

	R&S FSU3	R&S FSU8	R&S FSU26	
Setting range of refe	erence level	1.001000	1.0310020	
Logarithmic level	-130 dBm to (+5	dBm + RF attenuat	ion), max. 30 dBm,	
display		in steps of 0.1 dB		
Linear level display	7.0 n	V to 7.07 V in steps	of 1%	
Units of level axis	dBm, dBµV, dBr	nV, dBμA, dBpW (lo	og level display) /	
<b>.</b> .	μV, mV, μA,	mA, pW, nW (linear	level display)	
Level measurement	error	$< 0.2 / \sigma = 0.07 $ dB		
		<0.2 (0 = 0.07) ub		
<100 kHz reference				
level –30 dBm				
RF attenuation 10 dB				
Frequency response	DC coupling, RF att	enuation $\geq$ 10 dB)		
10 MHz to 3.6 GHz	<	$< 0.3 \text{ dB} (\sigma = 0.1 \text{ dB})$	) <sup>1)</sup>	
3.6 GHz to 8 GHz	_	<1.5 dB (o	$\sigma = 0.5 \text{ dB})^{2}$	
8 GHz to 22 GHz	-	-	<2 dB	
00.0U + 00.E.0U			$(\sigma = 0.7 \text{ dB})^{2}$	
22 GHz to 26.5 GHz	-	-	<2.5 dB	
Attonuctor (NE dP)		-0.2 dP/0.07 dl	$(\sigma = 0.8 \text{ GB})^{-7}$	
Reference level	-	$15 \text{ dB} (\sigma = 0.07 \text{ d})$	IR)	
switching			,	
Display nonlinearity	(20 °C to 30 °C, mi	xer level ≤–10 dBm	)	
Logarithmic level di	splay			
RBW ≤100 kHz, S/N	>20 dB			
0 dB to -70 dB	<	<0.1 dB ( $\sigma = 0.03$ dl	B)	
-/0 dB to -90 dB		$<$ 0.3 dB ( $\sigma$ = 0.1 dE	3)	
$10 \text{ MHz} \ge \text{KBW} \ge 20$	U  KHz, S/N > 16  dB	.02dD/= 002dl	DI	
_50 dB to _70 dB	<	$< 0.2 \text{ uB} (\sigma = 0.07 \text{ u})$		
RBW > 10 MHz			)	
0  dB to -50  dB	<	$< 0.5 \text{ dB} (\sigma = 0.17 \text{ d})$	B)	
Linear level display	5 % of reference level			
Bandwidth switchin	g error (ref. to RBV	<i>N</i> = 10 kHz)		
10 Hz to 100 kHz		-		
200 kHz to 10 MHz	<	<0.2 dB ( $\sigma = 0.07$ dl	B)	
5 MHz to 50 MHz	<	$< 0.5 \text{ dB} (\sigma = 0.15 \text{ d})$	B)	
Total managurament	<	$< 0.2 \text{ dB} (\sigma = 0.07 \text{ d})$	В)	
101  dl measurement $101  dl$ to $-70  dl$ S/N	≥20 dB_snan/BBW	/_100_95 % confid	ence level)	
(20 °C to 30 °C mixe	(0  ub  (0 - 70  ub, 3/1) > 20  ub,  span/hbw < 100, 30 % connuclice level) (20 °C to 30 °C mixer level <-10 dBm)			
<3.6 GHz	0.3	dB for RBW $\leq 100$	kHz	
	0.5	dB for RBW > 100	kHz	
3.6 GHz to 8 GHz	-	<2.	0 dB	
8 GHz to 18 GHz	-	-	<2.5 dB	
18 GHz to 26.5 GHz	-	-	<3.0 dB	
Audio demodulatio				
Modulation modes	laudana	AM and FM		
Marker hold time in	louuspea	100 ms to 60 s		
spectrum mode		100 113 10 00 3		
Trigger functions				
Trigger				
Span ≥10 Hz				
Trigger source	free run, video, ex	ternal, IF level (mixe	er level >-20 dBm)	
Trigger offset	125 ns to 100 s, re	esolution 125 ns mir	n. (or 1 % of offset)	
Span = 0 Hz				
Trigger source	free run, video, ex	ternal, IF level (mixe	er level >-20 dBm)	
Irigger offset	± 125 ns to	o TUU s, resolution 1	125 ns min.,	
Max doviation of	dej , /126	Denuent on SWeep t	une ( time))	
ivida. UEVIALION OF	± (125	o ns + (0.1 % X dela)	y uniejj	
Gated sween				
Trigger source	e	xternal, IF level. vid	eo	
Gate delay		1 µs to 100 s		
Gate length	125 ns to 100 s,	resolution min. 125	ns or 1 % of gate	
		length	-	
Max. deviation of	±(125 r	ns + (0.05 % x gate	length))	
gate length				

	R&S FSU3	R&S FSU8	R&S FSU26		
Inputs and output:	s (front panel)				
RF input		N female, 50 $\Omega$			
VSWR; RF attenuatio	/SWR; RF attenuation $\geq$ 10 dB, DC coupling				
f <3.6 GHz		<1.5			
f <8 GHz	-	<2.0	<1.8		
f <18 GHz	-	-	<1.8		
t <26.5 GHz	_	-	<2.0		
RF attenuation		typ. 1.5			
Setting range of	16 O	R to 75 dB in 5 dB st	one		
attenuator	0 01		ieha		
Probe power supply	+15 V DC -12 6 V DC and ground max 150 mA nominal				
Power supply for		5-pin connector			
antennas					
Supply voltages	±10 V and	ground, max. 100 n	nA nominal		
Keyboard					
Keyboard connector	PS/2	female for MF2 key	board		
AF output					
AF output		3.5 mm mini jack			
Output impedance		IU S2			
Open-circuit voltage	u (roar panol)	p to 1.5 v, aujustab	le		
IF 20 4 MHz		$-50 \Omega$ BNC form	alo		
Bandwidth	۲ <sub>01</sub>	<sub>it</sub> — 50 <b>22</b> , DNC lenia	16		
$\overline{\text{RBW}} \le 100 \text{ kHz}$	1.5 x resol	ution bandwidth. m	in. 2.6 kHz		
$10 \text{ MHz} \ge \text{RBW} \ge$	same	as resolution band	width		
200 kHz					
Level					
RBW ≤ 100 kHz, FFT	–20 dBm at ref	erence level, mixer l	evel >–70 dBm		
10 MHz≥RBW≥	0 dBm at refer	ence level, mixer le	vel >—50 dBm		
200 kHz					
IF 404.4 MHz	$Z_{out} = 50 \Omega$ , BNC female				
Dondwidth	404.4 IVIHZ IF OUTput active only If RBVV > 10 IVIHZ				
BBW > 10 MHz same as resolution bandwidth					
$Mixer level \le 0 dBm$	mixer level –10 d	B typ., only active if	BBW 20.50 MHz		
Video output	Z	$_{\rm t} = 50 \ \Omega$ , BNC fema	ale		
Voltage	0 V to 1 V, full sca	ale (open-circuit vol	tage), logarithmic		
(RBW ≥200 kHz)		scaling			
Reference frequency	1				
Output		BNC female			
Output frequency		10 MHz			
Level		>U dBm nominai			
Input frequency	1 MH	z to 20 MHz in 1 Hz	stans		
range	1 10111		31003		
Required level		>0 dBm from 50 $\Omega$			
Sweep output	BNC female, 0	V to 5 V, proportion	al to displayed		
		frequency			
Power supply con-	BNC fema	ale, 0 V and 28 V, sv	vitchable,		
nector for noise		max. 100 mA			
source					
External trigger/	E	3NC female, >10 k	2		
gate input		4.434			
Irigger voltage	interfec		- 400 2)		
remote control	Interfac	e to iec 020-2 (IEE	- 400.2)		
Command set		SCPI 1997 0			
Connector	24	-pin Amphenol fem	ale		
Interface functions	SH1, AH1, T6	, L4, SR1, RL1, PP1.	DC1, DT1, C0		
Serial interface	RS-232-0	C (COM), 9-pin SUB-	D female		
Printer interface	parallel (Centronics-compatible)				
Mouse connector		PS/2 female			
Connector for exter-	1	5-pin SUB-D female	9		
nal monitor (VGA)					

<sup>1)</sup> Valid for temperatures between +20 °C and +30 °C; <0.6 dB for temperatures between +5 °C and +45 °C.

General data				
Display	21 cm TFT LCD colour display (8.4")			
Resolution	800 x 600 pixels (SVGA resolution)			
Pixel failure rate	<1 x	10 -5		
Mass memory	1.44 Mbyte 3½" d	isk drive, hard disk		
Data storage	>500 instrument s	settings and traces		
Operating temperature	e range			
Rated temperature	+5 °C to	o +40 °C		
Limit temperature range	+0 °C to	) +50 °C		
Storage temperature range	−40 °C t	o +70 °C		
Damp heat	+40 °C at 95 % relative	e humidity (IEC 68–2–3)		
Mechanical resistance	)			
Vibration , sinusoidal	5 Hz to 150 Hz, max. 2 g at 55 Hz; 0.5 g from 55 Hz to 150 Hz; meets IEC 68-2-6, IEC 68-2-3, IEC 1010-1, MIL-T-28800D, class 5			
Vibration, random	10 Hz to 100 Hz, acceleration 1 g (rms)			
Shock test	40 g shock spectrum, meets MIL-STD-810C and MIL-T-28800D, classes 3 and 5			
Recommended	2 years for operation w	vith external reference,		
calibration interval	1 year with inte	ernal reference		
RFI suppression	meets EMC directive o German	f EU (89/336/EEC) and EMC law		
Power supply				
AC supply	100 V AC to 240 V AC, 3.1 A to 1.3 A, 50 Hz to 400 Hz, class of protection I to VDE 411			
Power consumption	typ. 130 VA	typ. 150 VA		
Safety	meets EN 61010-1, UL 3111-1, CSA C22.2 No. 1010-1, IEC 1010-1			
Test mark	VDE, GS, CS.	A, CSA-NRTL		
Dimensions (W x H x D)	435 mm x 192 mm x 460 mm	435 mm x 192 mm x 460 mm		
Weight	14.6 kg	15.4 kg		

#### Optional Extended Environmental Specification R&S FSU-B20

Temperature range (without condensation)			
Rated temperature range	0°C to +50°C		
Limit temperature range	0°C to +55°C		
Mechanical resistance			
Vibration, random	10 Hz to 300 Hz, acceleration 1.9 g (rms)		

#### Optional Electronic Attenuator R&S FSU-B25

Frequency				
Frequency range				
R&S FSU 3	S FSU 3 10 MHz to 3.6 GHz			
R&S FSU 8	10 MHz to 8 GHz			
R&S FSU 26	10 MHz to 3.6 GHz			
Setting range				
Electronic attenuator	0 dB to 30 dB, 5 dB steps			
Preamplifier 20 dB, switchable				
Maximum level measurement error				
Frequency response, with preamplifier or electronic attenuator				
10 MHz to 50 MHz	<1 dB			
50 MHz to 3.6 GHz <0.6 dB				
3.6 GHz to 8 GHz	<2.0 dB			
Reference error at 128 MHz, RBW ≤100 kHz, reference level –30 dBm,				
RF attenuation 10 dB				
Electronic attenuator	<0.3 dB			
Preamplifier	<0.3 dB			

<sup>2)</sup> Valid for temperatures between +20 °C and +30 °C and span <1 GHz; add < 0.5 dB for temperatures between +5 °C and +45 °C or span >1 GHz.

#### Displayed average noise level

 $\rm RBW{=}1~\rm kHz,~VBW{=}3~\rm kHz,~zero~span,~sweep~time~50~ms,~20~averages,~mean~marker,~normalized~to~10~\rm Hz~RBW$ 

Preamplifier on				
10 MHz to 2.0 GHz	<-152 dBm			
2.0 GHz to 3.6 GHz	<-150 dBm			
3.6 GHz to 8.0 GHz	<-147 dBm			
With the R&S FSU-B25 built in, the average noise level values displayed by the basic units degrade by (R&S FSU-B25 off):				
20 Hz to 3.6 GHz	1 dB			
3.6 GHz to 8 GHz	2 dB			
Preamplifier off, electronic attenuator 0 dB				
20 Hz to 3.6 GHz	typ. 2.5 dB			
3.6 GHz to 8 GHz typ. 3.5 dB				
Intermodulation				
Third-order intermodulation, third-order intercept (TOI), electronic attenuator on,				
$\Delta f$ > 5 x RBW or 10 kHz				
10 MHz to 300 MHz	>17 dBm			
300 MHz to 3.6 GHz	>20 dBm			
3.6 GHz to 8 GHz	>18 dBm			

### Ordering information

Order designation	Туре	Order No.
Spectrum Analyzer 20 Hz to 3.6 GHz	R&S FSU3	1129.9003.03
Spectrum Analyzer 20 Hz to 8 GHz	R&S FSU8	1129.9003.08
Spectrum Analyzer 20 Hz to 26.5 GHz	R&S FSU 26	1129.9003.26

#### Accessories supplied

Power cable, operating manual, service manual; R&S FSU26: test port adapter with 3.5 mm female (1021.0512.00) and N female (1021.0535.00) connector

#### **Options**

Order designation	Туре	Order No.
Options		
Delete Manual	R&S FSU-B0	1144.9998.02
Highly Accurate Reference Frequency	R&S FSU-B4	1144.9000.02
External Generator Control	R&S FSP-B10	1129.7246.02
LAN Interface100BT	R&S FSU-B16	1144.9498.02
Removable Hard Disk	R&S FSU-B181) 2)	1145.0242.02
Second Hard Disk for FSU-B18	R&S FSU-B19 <sup>2)</sup>	1145.0394.02
Extended Environmental Specification	R&S FSU-B203)	1155.1606.04
Electronic Attenuator, 0 dB to 30 dB,	R&S FSU-B25	1144.9298.02
with integrated 20 dB preamplifier		
Software		
Noise Measurement Software	R&S FS-K3	1057.3028.02
Phase Noise Measurement Software	R&S FS-K4	1108.0088.02
GSM/EDGE Application Firmware	R&S FS-K5	1141.1496.02
FM Measurement Demodulator	R&S FS-K7	1141.1796.02
3GPP BTS/Node B FDD Application	R&S FS-K72	1154.7000.02
Firmware		
Service Kit	R&S FSU-Z1	1145.0042.02

1) Factory installation only.

2) Not with R&S FSU-B20.

3) Not with R&S FSU-B18/-B19.

### Recommended extras

Order designation	Туре	Order No.	
Microwave Measurement Cable with	R&S FSE-Z15	1046.2002.02	
Adapter Set (for R&S FSU26 only)			
Headphones	-	0708.9010.00	
US Keyboard with trackball	R&S PSP-Z2	1091.4100.02	
PS/2 Mouse	R&S FSE-Z2	1084.7043.02	
Colour Monitor, 17", 230 V	R&S PMC3	1082.6004.04	
IEC/IEEE-Bus Cable, 1 m	R&S PCK	0292.2013.10	
IEC/IEEE-Bus Cable, 2 m	R&S PCK	0292.2013.20	
19" Rack Adapter	R&S ZZA-411	1096.3283.00	
Adapter for mounting on telescopic	R&S ZZA-T45	1109.3774.00	
rails (only with 19" Adapter ZZA-411)			
Matching Pads, 75 $\Omega$	•		
L Section	R&S RAM	0358.5414.02	
Series Resistor, 25 $\Omega$	R&S RAZ	0358.5714.02	
SWR Bridge, 5 MHz to 3000 MHz	R&S ZRB2	0373.9017.52	
SWR Bridge, 40 kHz to 4 GHz	R&S ZRC	1039.9492.52	
High-Power Attenuators, 100 W,			
3/6/10/20/30 dB	R&S RBU 100	1073.8820.XX	
		(XX=03/06/10/20/30)	
High-Power Attenuators, 50 W			
3/6/10/20/30 dB	R&S RBU 50	1073.8895.XX	
		(XX=03/06/10/20/30)	
20 dB, 6 GHz	R&S RDL 50	1035.1700.52	

Certified Environmental System



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